

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

JUESTEL ET AL.

Examiner

NOAH S. WIESE

Art Unit

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2003/0052595	03-2003	Ellens et al.	313/501
*	B US-2006/0033081	02-2006	Hintzen et al.	252/301.40F
C	US-			
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H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
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X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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